

# Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		30	V
V <sub>GSS</sub>	Gate-Source Voltage		± 20	V
I <sub>D</sub>	Drain Current – Continuous	(Note 1)	100	A
			75	
	- Pulsed	(Note 1)	300	
P <sub>D</sub>	Total Power Dissipation @ $T_c = 25^{\circ}C$		107	W
	Derate above 25	j°C	0.7	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +175	°C

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.4	°C/W
R <sub>BJA</sub> Thermal Resistance, Junction-to-Ambient		62.5	°C/W

# Package Marking and Ordering Information

 Device Marking	Device	Reel Size	Tape width	Quantity
 FDB7045L	FDB7045L	13"	24mm	800 units
FDP7045L	FDP7045L	Tube	n/a	45

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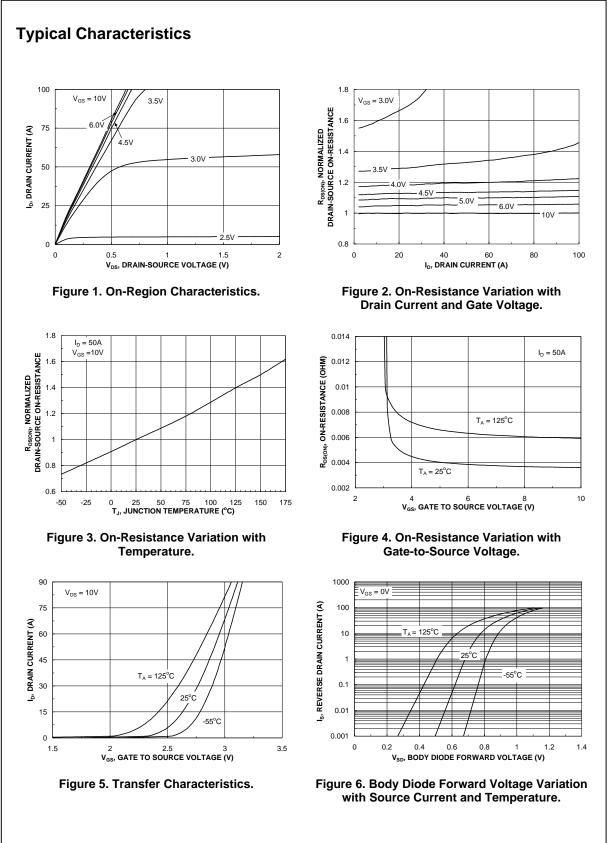
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Sc	Durce Avalanche Ratings (Note	1)				
W <sub>DSS</sub>	Single Pulse Drain-Source	$V_{DD} = 15 \text{ V},  I_D = 75 \text{ A}$			330	mJ
I <sub>AR</sub>	Avalanche Energy Maximum Drain-Source Avalanche				75	A
Off Char	Current acteristics					
			20			V
	Drain–Source Breakdown Voltage Breakdown Voltage Temperature	$V_{GS} = 0 V, \qquad I_D = 250 \ \mu A$ $I_D = 250 \ \mu A, \text{ Referenced to } 25^{\circ}\text{C}$	30	25		v mV/°C
$\Delta T_{J}$	Coefficient Zero Gate Voltage Drain Current	<u> </u>			1	A
		$V_{DS} = 24 V, V_{GS} = 0 V$				μA
	Gate–Body Leakage	$V_{GS}=\pm~20~V, V_{DS}=0~V$			± 100	nA
	acteristics (Note 2)	T				
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_D = 250 \ \mu A$	1	1.8	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to $25^{\circ}$ C		-6		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–	$V_{GS} = 10 \text{ V}, \qquad I_D = 50 \text{ A}$		3.5	4.5	mΩ
	Resistance	$V_{GS} = 4.5 \text{ V},  I_D = 40 \text{ A}$		4.0 5.5	6.0 7.0	
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS}$ = 10 V, $I_D$ = 50 A, $T_J$ =125°C $V_{GS}$ = 10 V, $V_{DS}$ = 10 V	50	5.5	7.0	A
	Forward Transconductance	$V_{\rm DS} = 5V$ , $I_{\rm D} = 50$ A	50	165		S
g <sub>FS</sub>		$V_{DS} = 0V$ , $I_D = 00 A$		100		0
C <sub>iss</sub>	Characteristics			4357		pF
		$V_{DS} = 15 V$ , $V_{GS} = 0 V$ , f = 1.0 MHz				•
Coss	Output Capacitance			1092		pF
C <sub>rss</sub>	Reverse Transfer Capacitance Gate Resistance	(1 - 1)		399 1.4		pF
R <sub>G</sub>		$V_{GS} = 15 \text{ mV}, \text{ f} = 1.0 \text{ MHz}$		1.4		Ω
Switchin	g Characteristics (Note 2)		1	1		1
t <sub>d(on)</sub>	Turn–On Delay Time	$V_{DD} = 15V,$ $I_D = 1 A,$ $V_{GS} = 10 V,$ $R_{GEN} = 6 \Omega$		16	29	ns
t <sub>r</sub>	Turn–On Rise Time	$V_{GS} = 10$ V, $R_{GEN} = 0.22$		13	24	ns
t <sub>d(off)</sub>	Turn–Off Delay Time	-		74	119	ns
t <sub>f</sub>	Turn–Off Fall Time			41	66	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = 15 \text{ V}, \qquad I_D = 50 \text{ A}, \\ V_{GS} = 5 \text{ V}$		41	58	nC
Q <sub>gs</sub>	Gate-Source Charge	4		12		nC
Q <sub>gd</sub>	Gate–Drain Charge			14		nC
Drain-S	ource Diode Characteristics					1
ls	Maximum Continuous Drain-Source	Diode Forward Current			75	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS}=0~V,~~I_S=50~A~~(Note~1)$		0.91	1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>F</sub> = 50 A,		48		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge	$d_{iF}/d_{t} = 100 \text{ A}/\mu \text{s}$		42		nC

Notes:

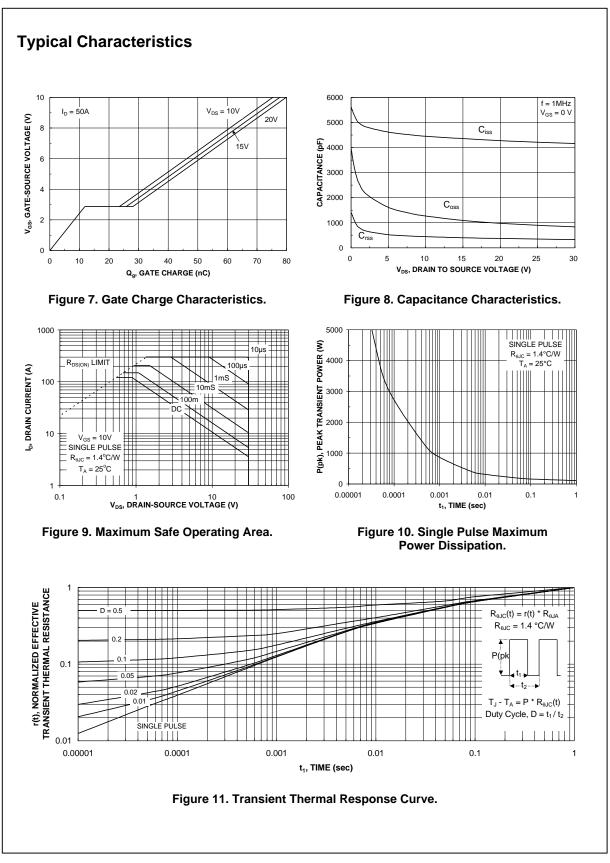
1. Calculated continuous current based on maximum allowable junction temperature. Actual maximum continuous current limited by package constraints to 75A.

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

FDP7045L/FDB7045L



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